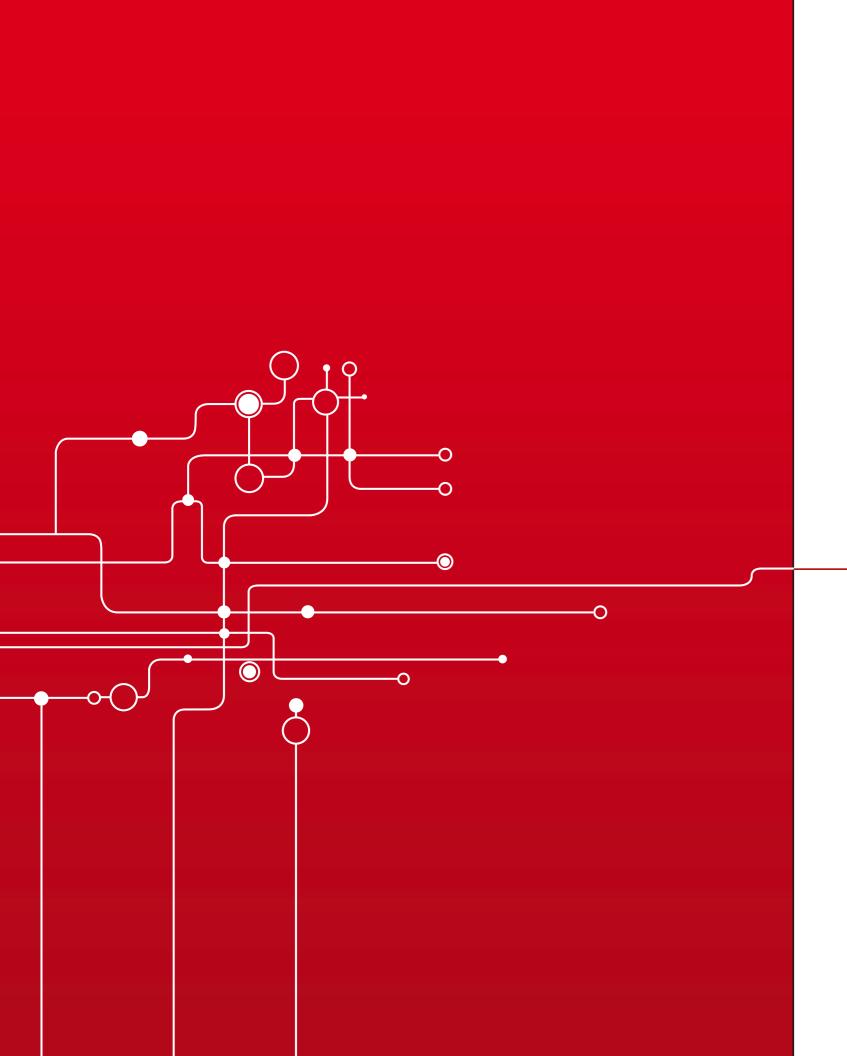
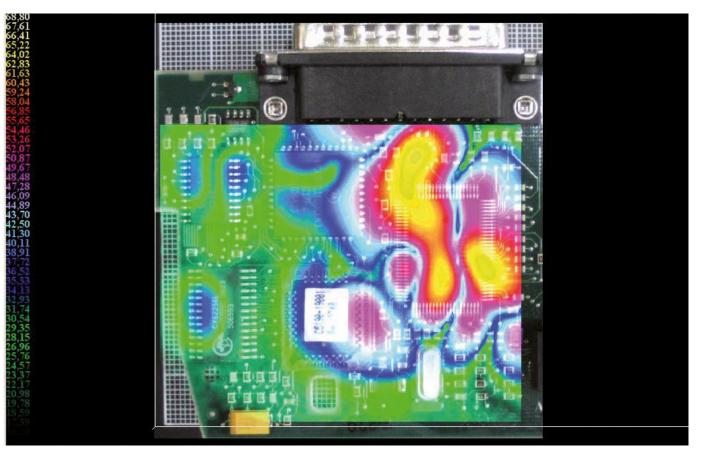
# EMC-scanner RSE-series







Print Screen image of a scan measurement.

# Seeing high frequencies!

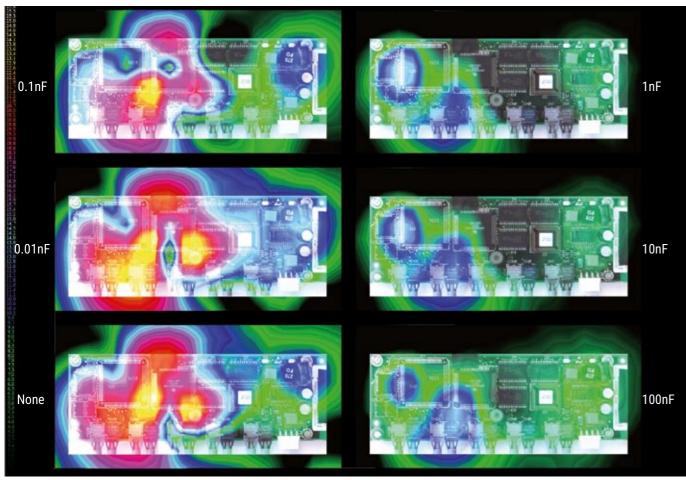
Now you can SEE high frequency electromagnetic fields.

# The background

There are high demands for electromagnetic compatibility (EMC) of electronic products. The demands are stated in different set of rules, for example: VCCI, ANSI, CISPR, FCC and VDE. These demands are specified for products or systems and not for components or elements. The fact that there is no easy way to find the exact location of a radiating source is a problem for designers today.

Detectus AB has developed several measuring systems with which designers can measure the intensity and the location of a radiation source at a component level. The results of such a measurement can be shown as two or three dimensional coloured maps. The measurements can easily be repeated creating objective, comparative measurement results.

FEATURES FEATURES



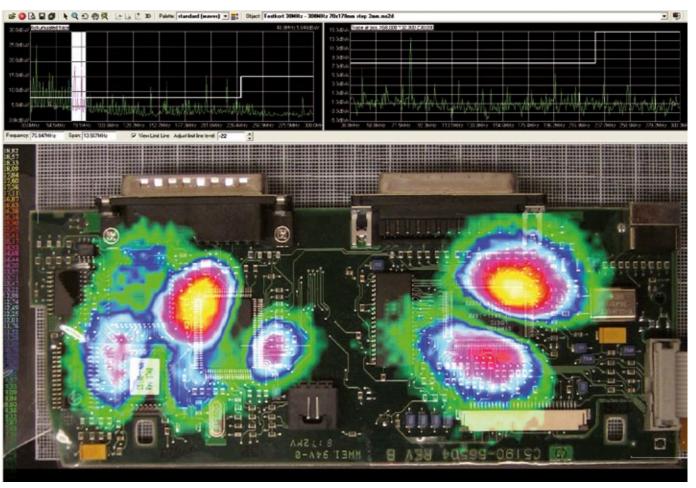
Six Scan measurements with different de-coupling

### Visual noise detection

The patented EMC-Scanner measures the emission from components, cables, PCB's and products. The system consists of an X-Y-Z robot, a spectrum analyzer with near field probe and a standard PC with custom software and a GPIB card or similar for communicating with the spectrum analyzer. During measurement the near field probe is moved by the robot to predetermined measuring points above the test object.

### Objective comparative measurements

One of the most useful features of the EMC-Scanner system is that it enables you to make truly objective comparative measurements. Above, you can see an example of comparative measurements. The six measurements show the same test object and the same frequency. The difference is the value of the de-coupling capacitor of one IC.



MultiScan measurement. The top left graph shows the accumulated trace (a max hold spectra of all measuring points). The top right graph shows the wide band spectra from a user selectable spot on the field plot.

### Ease of use

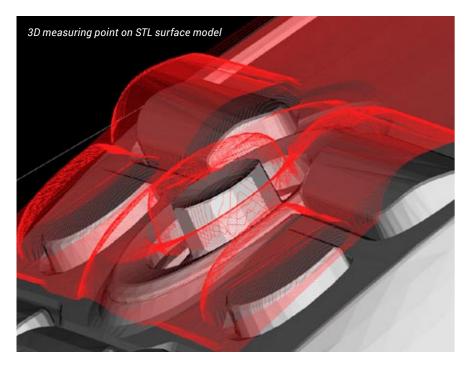
Earlier emission measurements had to be made by specialists. With the EMC-Scanner anyone can make a measurement and draw conclusions from the informative and easily interpreted reports. You do not even need to have access to a screened room to make the measurements. The software runs in Windows on a standard PC and is intuitive and user-friendly. Since the system is configurable for most modern spectrum analyzers, you can use your own and do not have to purchase a new one.

### MultiScan

The MultiScan measurement enables you to generate field plots from any frequency within the measured wide band span. This powerful feature is a major improvement and it gives an enormous amount of information. Looking at the screen dump above, the main part of the screen shows the field plot of the frequency selected in the top left graph. The upper right graph shows the spectra from a user selectable position.

**SCANNERS SCANNERS** 





# A complete system

To complete the Scanner system you would need a PC, a near field probe and a spectrum analyzer. Near field probes and a spectrum analyzer can be provided by Detectus. Depending on your choice of spectrum analyzer you may also need an National Instruments GPIB adapter.

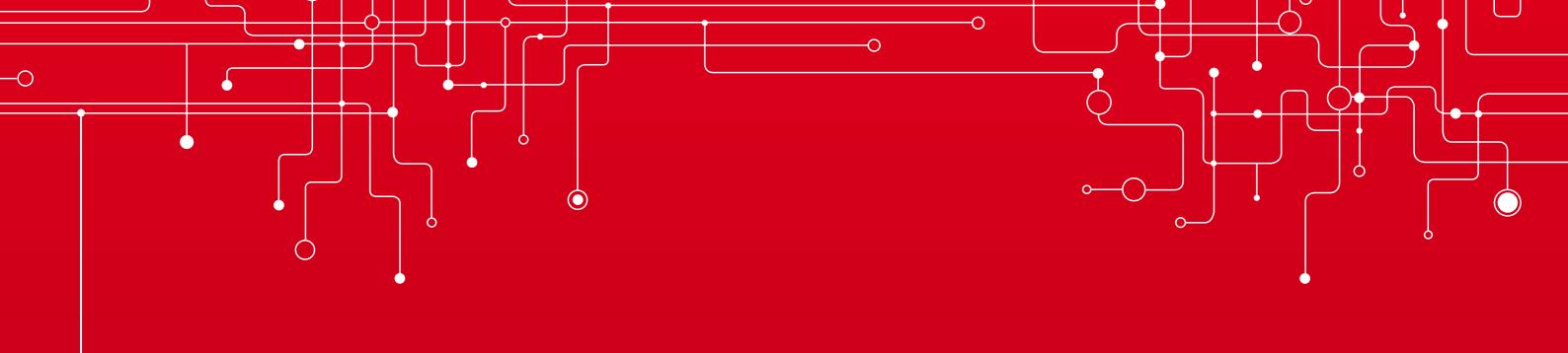
# Import 3D surface models

Now you can import 3D surface models in STL file format and create measuring points that follow the surface at a fixed distance. 3D surface models can easily be aligned to the measurement using the 3-point alignment feature.



### Tochnical data

lechnical data			
Accuracy:	+/- 0.3 mm		
Min step size:	1 mm		
Line voltage:	115 or 230V, 50 or 60 Hz		
Speed:	5000 mm/min		
Control:	Ethernet, RS-232 or USB to RS-232 adapter		
Software:	Runs on Windows XP or later. (32- and 64-bit) Also runs om Mac using BootCamp		
Modell:	RSE-321	RSE-642	RSE-644
Measurable volume (mm):	300x200x100	600x400x200	600x400x400
Movement XYZ-axes (mm):	300x200x100	600x400x200	600x400x200
Size (w/h/d in mm):	620x500x550	920x700x750	920x700x950



# Why the EMC-scanner

- You can *save time and money* by reducing your need for expensive and time consuming full scale measurements
- You can make *comparative measurements* to document the effect of a change in design.
- You can maintain a *high quality* in the production line by measuring samples and comparing them to a reference.
- You can subtract one measurement from another to remove ambient noise or to be able to see the difference between two products more clearly.
- 5 You can use your own instruments.

- 6 You can *see the emission* at components level.
- Early in the design phase you can **detect potential emission problems**.
- You do not have to know what frequencies you are looking for thanks to the Pre-Scan and MultiScan functions.
- You can *easily document* (ISO 900x) the emission spectra of your products in both design and production phase.

### Design

Using the EMC-Scanner during the early stages of design enables you to detect potential emission problems before they become integrated into the product and expensive to correct.

If a product has failed a test at a test house, normally you only know which frequency failed. You don't get to know the location of the source.

The EMC-Scanner can help you find the source and repeated measurements while redesigning your product helps you lower the emission levels.

# Q&A tool

The EMC-Scanner can help you maintain a high quality in the production line. You can make measurements on samples from the production line and easily compare them with a reference. That way you can make sure that, for example, a change of supplier of a component doesn't affect the emission spectra in a negative way.

HEAT SCANNER HEAT SCANNER

# Measure **temperature**

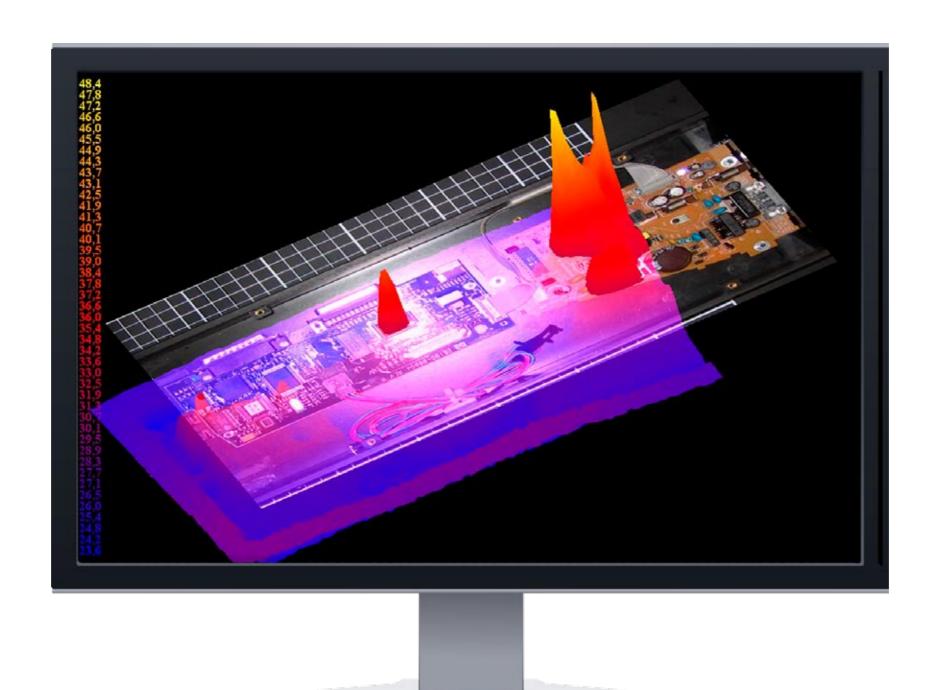
### High Resolution Heat Scanner

Why should you, as a designer, be without the ability to measure the temperature of your products? Is this due to cost or inaccessibility? In that case, the solution is the heat scanner from Detectus AB. Heat scanner is a high-resolution measuring system for anyone wishing to measure temperature accurately and inexpensively. The measurements are presented graphically as either two or three-dimensional images.

The Heat-Scanner feature is included in the EMC Scanner product!

### Precision

The system's 16 bits digital resolution, the software's optimization method as well as the ability to adjust offset and emission factors result in high resolution measurements. The system gives you the possibility to localize small heat sources such as surface mounted components.



## Why heat scanner?

- You can Increase your product's life time by optimizing design taking consideration to temperature.
- You see the heat spreads out at detail level.
- You can detect heat problems early in the design stage.
- You can make comparative measurements quickly and easily.
- Increase quality by comparing products under production through measurement of a properly functioning master.
- You can measure and document the temperature over a period of time.
- You can subtract one measurement from another to be able to see the difference between two products more clearly.

### Technical data

Temperature range:	0-150 °C
Resolution:	+/- 0.3 °C
Measuring spot:	6 mm diameter at a distance of 200 mm.
Response time:	500 ms
Emission ratio:	0,1 - 1,2
Spectral response:	8 - 14 µm

• (10) EMC-Scanner **RSE-series** 

OPTIONS OPTIONS

# Immunity software option

### Visual Immunity test

The patented Immunity software option allows you to use a Detectus EMC-Scanner system, a signal generator with a small antenna and an Error Detection Device (EDD) to measure the immunity against radiated electro magnetic interference of components, cables, PCB's and products. The measurements are easily interpreted and can be repeated for objective comparison.

### Measurements and reports

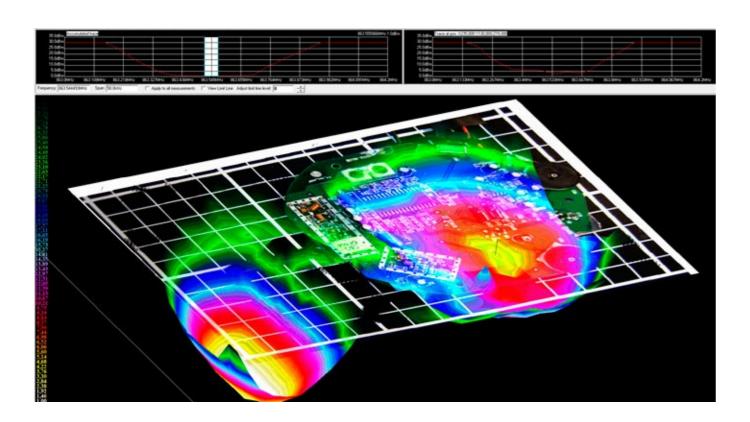
From an Immunity Scan measurement the DSS software can produce two or three dimensional colour maps showing sensitive hot spots at any frequency. Also printable reports can be generated. The reports include the colour map, graphs and all the measurement settings.

### The measuring procedure

During measurement the EMC-scanner moves the antenna to predetermined measuring positions above the test object. In each measuring position the signal generator sweeps in frequency and amplitude while the EDD measures for test object failure. If your signal generator allows it, you can also use different modulations such as FM, AM and Pulse

### Use any Error detection device

The Error Detection Device can be any type of GPIB or VISA controllable instrument that measures a value from the test object to determine when the test object fails. The EDD can for example be a voltmeter or a protocol tester.





# Probe & Pre-amplifier kit

The kit Includes a set of four specially selected near field probes, a 30 dB pre-amplifier (PA 303) and RF cables (RG 316U).

### The probe set contains:

RF-E 03 E-field 30MHz-3GHz
RF-B 0,3-3 Vert. H-field, 30MHz-3GHz
RF-R 0,3-3 Horiz. H-field, 30MHz-3GHz
LF-B 3 Vert. H-field, 9kHz-50MHz

6GHz versions of the RF-probes are also available.





# Strip line calibration

The new strip line calibration feature enables you to accurately measure the field strength of the magnetic near field and to compare measurements made with different probes and setups.

### The Strip line

The strip line calibration feature uses a well defined strip line board and a spectrum analyzer with built in tracking generator to automatically generate a set of probe correction factors in Detectus Scanner Software. The correction factors will compensates for imperfections in the probe, cables, connectors and pre-amp.

### Calibration procedure

The calibration procedure only takes a few minutes and is very easy to perform. Just follow the step-by-step wizard. The wizard includes detailed instructions on how to connect everything and setup the calibration measurement. Calibration can be made on any magnetic near field probe and covers a frequency range from 10 MHz to 6 GHz

See it before you **C€** it!

